

# FMI06N60ES

FUJI POWER MOSFET

## Super FAP-E<sup>3S</sup> series

## N-CHANNEL SILICON POWER MOSFET

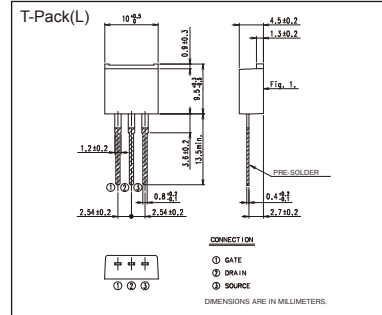
### ■ Features

- Maintains both low power loss and low noise
- Lower  $R_{DS(on)}$  characteristic
- More controllable switching  $dV/dt$  by gate resistance
- Smaller  $V_{GS}$  ringing waveform during switching
- Narrow band of the gate threshold voltage ( $3.7 \pm 0.5V$ )
- High avalanche durability

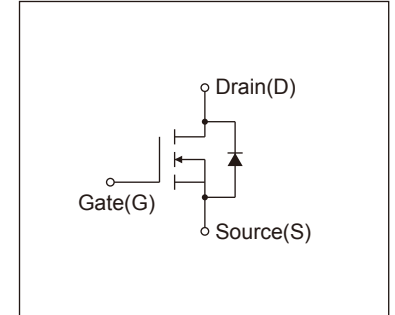
### ■ Applications

- Switching regulators
- UPS (Uninterruptible Power Supply)
- DC-DC converters

### ■ Outline Drawings [mm]



### ■ Equivalent circuit schematic



### ■ Maximum Ratings and Characteristics

#### ● Absolute Maximum Ratings at $T_c=25^\circ\text{C}$ (unless otherwise specified)

| Description   | Symbol    | Characteristics | Unit              | Remarks                |
|---|-----------|-----------------|-------------------|------------------------|
| Drain-Source Voltage                                    | $V_{DS}$  | 600             | V                 |                        |
|   | $V_{DSX}$ | 600             | V                 | $V_{GS} = -30V$        |
| Continuous Drain Current                                | $I_D$     | $\pm 6$         | A                 |                        |
| Pulsed Drain Current                                    | $I_{DP}$  | $\pm 24$        | A                 |                        |
| Gate-Source Voltage                                     | $V_{GS}$  | $\pm 30$        | V                 |                        |
| Repetitive and Non-Repetitive Maximum Avalanche Current | $I_{AR}$  | 6               | A                 | Note*1                 |
| Non-Repetitive Maximum Avalanche Energy                 | $E_{AS}$  | 313.7           | mJ                | Note*2                 |
| Repetitive Maximum Avalanche Energy                     | $E_{AR}$  | 10.5            | mJ                | Note*3                 |
| Peak Diode Recovery $dV/dt$                             | $dV/dt$   | 3.8             | kV/ $\mu\text{s}$ | Note*4                 |
| Peak Diode Recovery $-di/dt$                            | $-di/dt$  | 100             | A/ $\mu\text{s}$  | Note*5                 |
| Maximum Power Dissipation                               | $P_D$     | 1.67            | W                 | $T_a=25^\circ\text{C}$ |
|   |           | 105             |                   | $T_c=25^\circ\text{C}$ |
| Operating and Storage Temperature range                 | $T_{ch}$  | 150             | $^\circ\text{C}$  |                        |
|   | $T_{stg}$ | -55 to +150     | $^\circ\text{C}$  |                        |

#### ● Electrical Characteristics at $T_c=25^\circ\text{C}$ (unless otherwise specified)

| Description                      | Symbol       | Conditions   | min. | typ. | max. | Unit          |
|----------------------------------|--------------|--|------|------|------|---------------|
| Drain-Source Breakdown Voltage   | $BV_{DSS}$   | $I_D=250\mu\text{A}$ , $V_{GS}=0V$                       | 600  | -    | -    | V             |
| Gate Threshold Voltage           | $V_{GS(th)}$ | $I_D=250\mu\text{A}$ , $V_{DS}=V_{GS}$                   | 3.2  | 3.7  | 4.2  | V             |
| Zero Gate Voltage Drain Current  | $I_{DSS}$    | $V_{DS}=600V$ , $V_{GS}=0V$ , $T_{ch}=25^\circ\text{C}$  | -    | -    | 25   | $\mu\text{A}$ |
|                                  |              | $V_{DS}=480V$ , $V_{GS}=0V$ , $T_{ch}=125^\circ\text{C}$ | -    | -    | 250  |               |
| Gate-Source Leakage Current      | $I_{GSS}$    | $V_{GS}=\pm 30V$ , $V_{DS}=0V$                           | -    | 10   | 100  | nA            |
| Drain-Source On-State Resistance | $R_{DS(on)}$ | $I_D=3A$ , $V_{GS}=10V$                                  | -    | 1.03 | 1.20 | $\Omega$      |
| Forward Transconductance         | $g_{fs}$     | $I_D=3.0A$ , $V_{DS}=25V$                                | 2.5  | 5    | -    | S             |
| Input Capacitance                | $C_{iss}$    | $V_{DS}=25V$   | -    | 950  | 1425 | pF            |
| Output Capacitance               | $C_{oss}$    | $V_{GS}=0V$  | -    | 100  | 150  |               |
| Reverse Transfer Capacitance     | $C_{rss}$    | $f=1\text{MHz}$  | -    | 7.5  | 11   |               |
| Turn-On Time                     | $t_{d(on)}$  | $V_{cc}=300V$  | -    | 29   | 43.5 | ns            |
|                                  | $t_r$        | $V_{GS}=10V$   | -    | 15   | 22.5 |               |
| Turn-Off Time                    | $t_{d(off)}$ | $I_D=3.0A$   | -    | 75   | 113  |               |
|                                  | $t_f$        | $R_G=27\Omega$   | -    | 16   | 24   |               |
| Total Gate Charge                | $Q_G$        | $V_{cc}=300V$  | -    | 31   | 46.5 | nC            |
| Gate-Source Charge               | $Q_{GS}$     | $I_D=6A$   | -    | 10.5 | 15.8 |               |
| Gate-Drain Charge                | $Q_{GD}$     | $V_{GS}=10V$   | -    | 8    | 12   |               |
| Gate-Drain Crossover Charge      | $Q_{SW}$     |  | -    | 4.5  | 6.75 |               |
| Avalanche Capability             | $I_{AV}$     | $L=6.39\text{mH}$ , $T_{ch}=25^\circ\text{C}$            | 6    | -    | -    | A             |
| Diode Forward On-Voltage         | $V_{SD}$     | $I_F=6A$ , $V_{GS}=0V$ , $T_{ch}=25^\circ\text{C}$       | -    | 0.90 | 1.35 | V             |
| Reverse Recovery Time            | $t_{rr}$     | $I_F=6A$ , $V_{GS}=0V$                                   | -    | 0.4  | -    | $\mu\text{s}$ |
| Reverse Recovery Charge          | $Q_{rr}$     | $-di/dt=100A/\mu\text{s}$ , $T_{ch}=25^\circ\text{C}$    | -    | 3.3  | -    | $\mu\text{C}$ |

#### ● Thermal Characteristics

| Description        | Symbol         | Test Conditions    | min. | typ. | max. | Unit               |
|--------------------|----------------|--------------------|------|------|------|--------------------|
| Thermal resistance | $R_{th(ch-c)}$ | Channel to case    |      |      | 1.19 | $^\circ\text{C/W}$ |
|                    | $R_{th(ch-a)}$ | Channel to ambient |      |      | 75.0 | $^\circ\text{C/W}$ |

Note \*1 :  $T_{ch} \leq 150^\circ\text{C}$

Note \*2 : Stating  $T_{ch}=25^\circ\text{C}$ ,  $I_{AS}=2.4A$ ,  $L=99.8\text{mH}$ ,  $V_{cc}=60V$ ,  $R_G=50\Omega$   
 $E_{AS}$  limited by maximum channel temperature and avalanche current.  
 See to 'Avalanche Energy' graph.

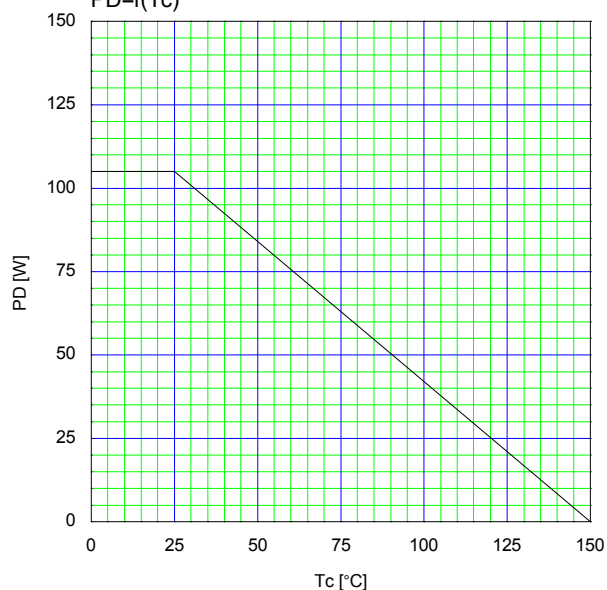
Note \*3 : Repetitive rating : Pulse width limited by maximum channel temperature.

See to the 'Transient Thermal Impedance' graph.

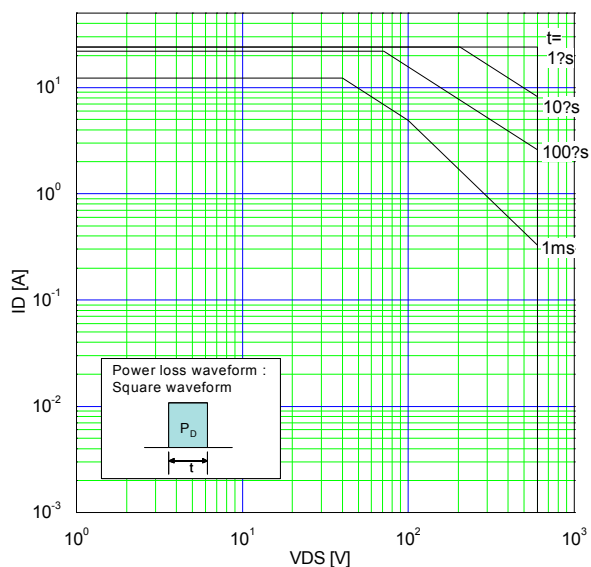
Note \*4 :  $I_F \leq I_D$ ,  $-di/dt=100A/\mu\text{s}$ ,  $V_{cc} \leq BV_{DSS}$ ,  $T_{ch} \leq 150^\circ\text{C}$ .

Note \*5 :  $I_F \leq I_D$ ,  $dV/dt=3.8kV/\mu\text{s}$ ,  $V_{cc} \leq BV_{DSS}$ ,  $T_{ch} \leq 150^\circ\text{C}$ .

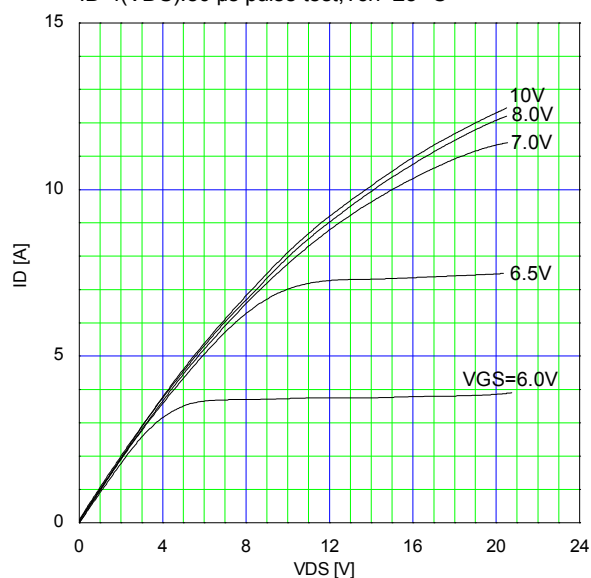
Allowable Power Dissipation  
 $P_D = f(T_c)$



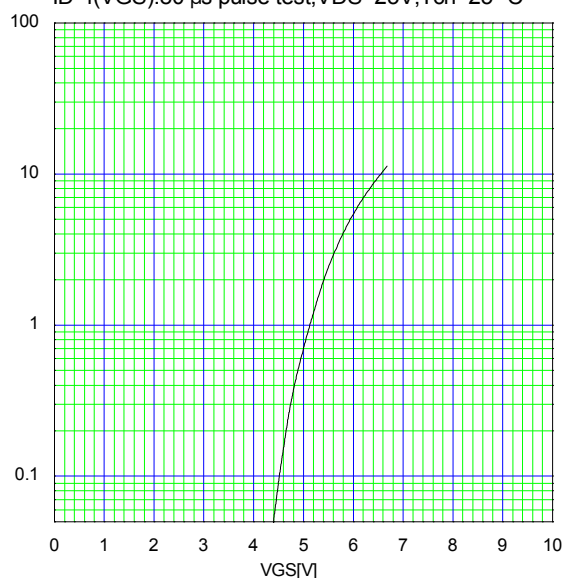
Safe Operating Area  
 $I_D = f(V_{DS})$ ; Duty=0 (Single pulse),  $T_c = 25$  °C



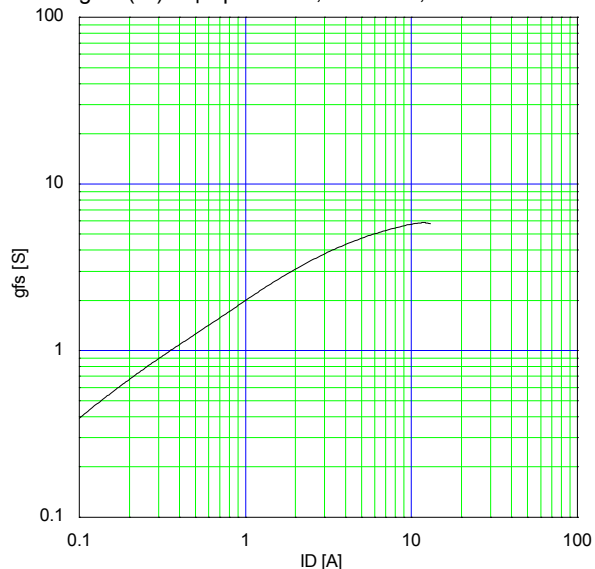
Typical Output Characteristics  
 $I_D = f(V_{DS})$ ; 80  $\mu$ s pulse test,  $T_{ch} = 25$  °C



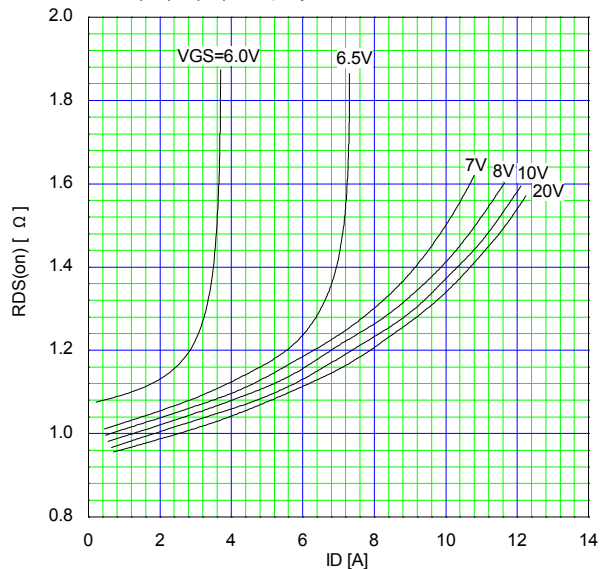
Typical Transfer Characteristic  
 $I_D = f(V_{GS})$ ; 80  $\mu$ s pulse test,  $V_{DS} = 25$  V,  $T_{ch} = 25$  °C



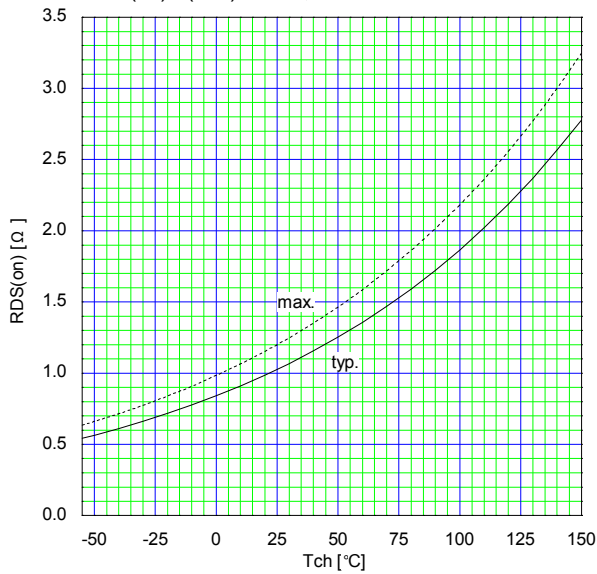
Typical Transconductance  
 $g_{fs} = f(I_D)$ ; 80  $\mu$ s pulse test,  $V_{DS} = 25$  V,  $T_{ch} = 25$  °C



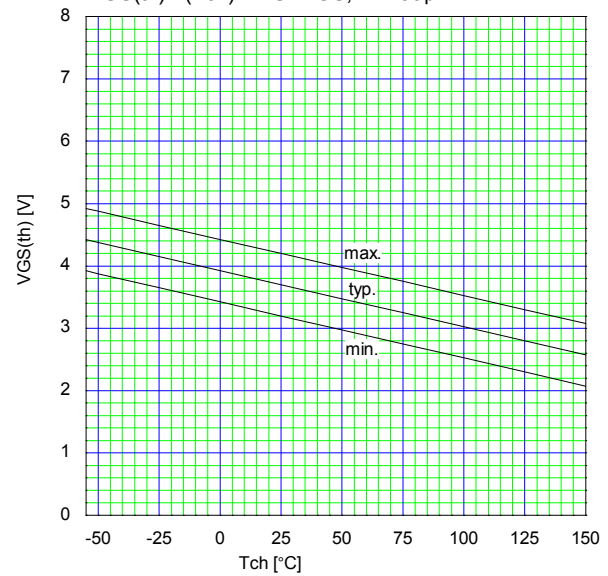
Typical Drain-Source on-state Resistance  
 $R_{DS(on)} = f(I_D)$ ; 80  $\mu$ s pulse test,  $T_{ch} = 25$  °C



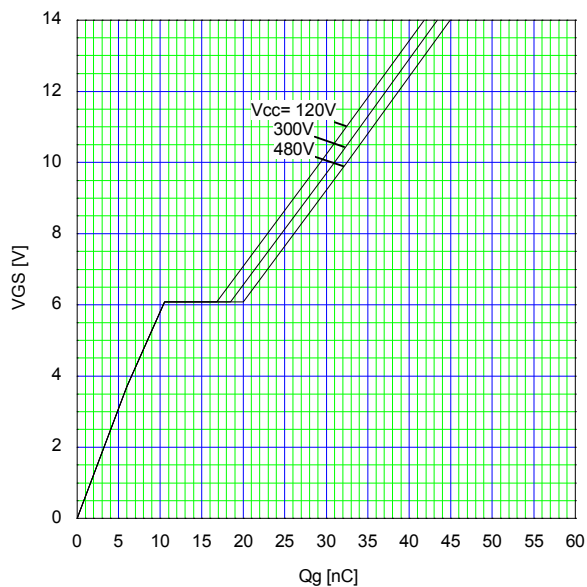
Drain-Source On-state Resistance  
 $R_{DS(on)} = f(T_{ch}): I_D = 3A, V_{GS} = 10V$



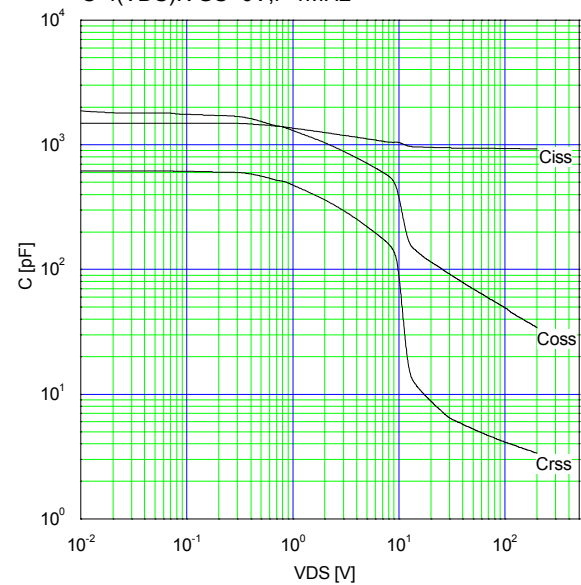
Gate Threshold Voltage vs.  $T_{ch}$   
 $V_{GS(th)} = f(T_{ch}): V_{DS} = V_{GS}, I_D = 250\mu A$



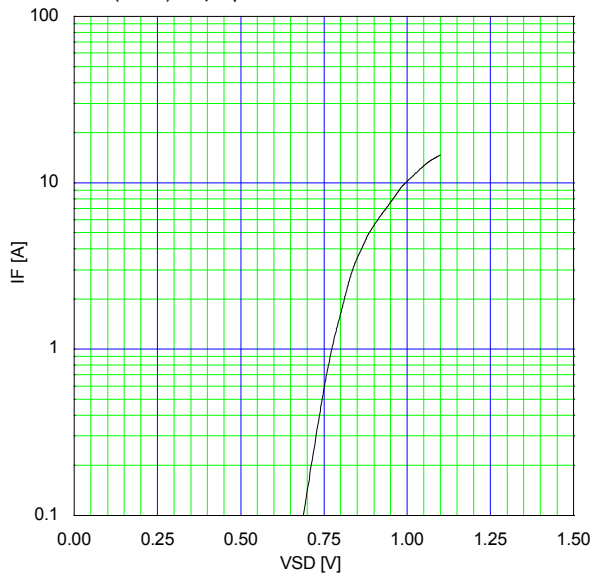
Typical Gate Charge Characteristics  
 $V_{GS} = f(Q_g): I_D = 6A, T_{ch} = 25^{\circ}C$



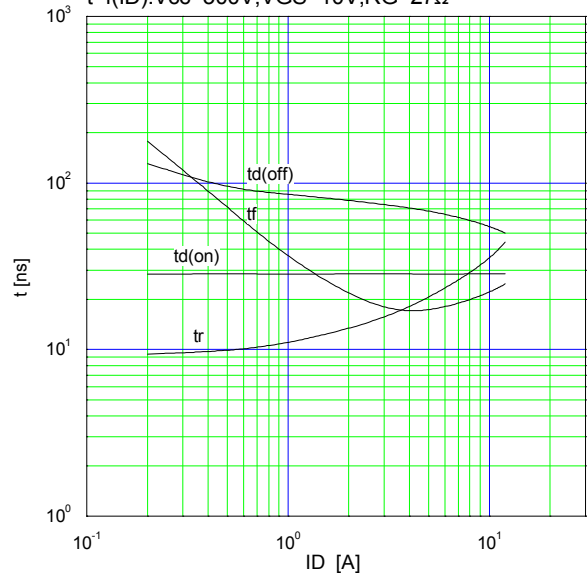
Typical Capacitance  
 $C = f(V_{DS}): V_{GS} = 0V, f = 1MHz$

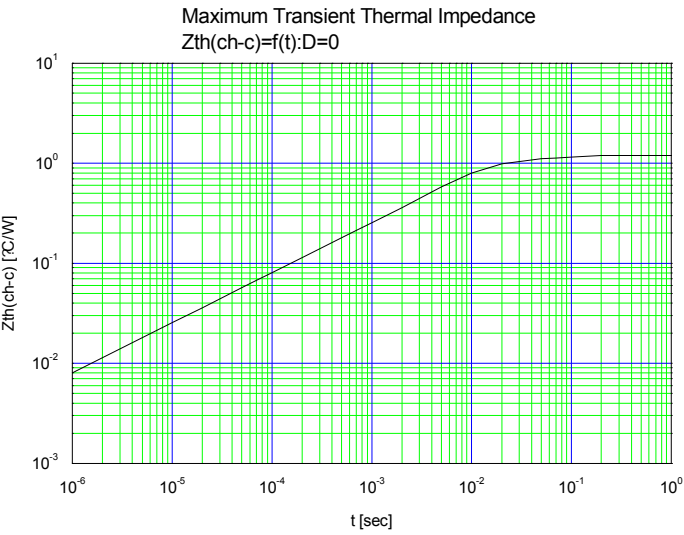
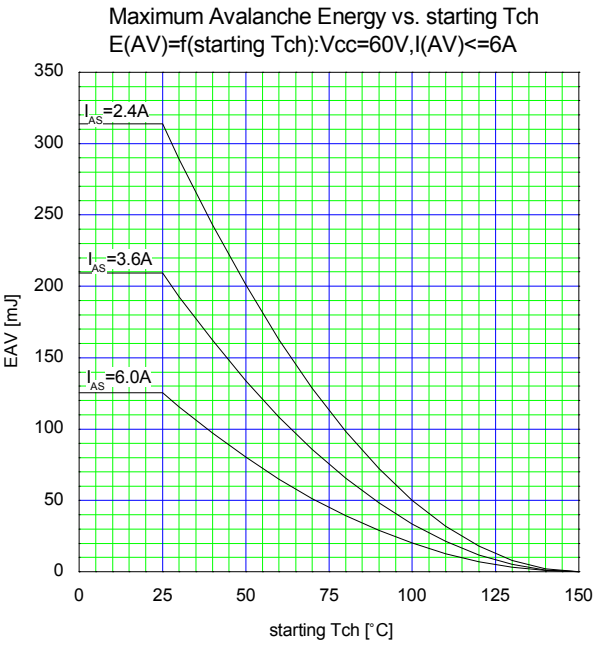


Typical Forward Characteristics of Reverse Diode  
 $I_F = f(V_{SD}): 80\mu s$  pulse test,  $T_{ch} = 25^{\circ}C$



Typical Switching Characteristics vs.  $I_D$   
 $t = f(I_D): V_{CC} = 300V, V_{GS} = 10V, R_G = 27\Omega$





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